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20-V N-Channel NexFET™ Power MOSFETs

Check for Samples: CSD15571Q2

FEATURES

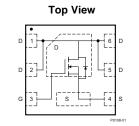
- Ultralow Q_g and Q_{gd}
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- RoHS Compliant
- Halogen Free
- SON 2-mm × 2-mm Plastic Package

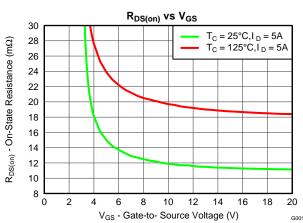
APPLICATIONS

- Optimized for Load Switch Applications
- Storage, Tablets, and Handheld Devices
- Optimized for Control FET Applications
- Point of Load Synchronous Buck Converters

DESCRIPTION

The NexFET[™] power MOSFET has been designed to minimize losses in power conversion and load management applications. The SON 2x2 offers excellent thermal performance for the size of the package.





PRODUCT SUMMARY

V _{DS}	Drain to Source Voltage	20	V	
Qg	Gate Charge Total (4.5V)	2.5	nC	
Q _{gd}	Gate Charge Gate to Drain	0.66	nC	
	Drain to Source On Resistance	$V_{GS} = 4.5V$	16	mΩ
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10V$	12	mΩ
V _{GS(th)}	Threshold Voltage	1.45	V	

ORDERING INFORMATION

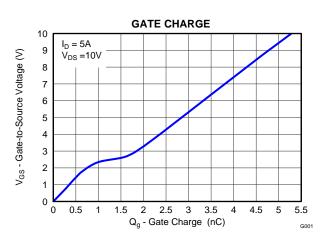
Device	Package	Media	Qty	Ship	
CSD15571Q2	SON 2-mm × 2-mm Plastic Package	7-Inch Reel	3000	Tape and Reel	

ABSOLUTE MAXIMUM RATINGS

T _A = 2	5°C unless otherwise stated	VALUE	UNIT
V_{DS}	Drain to Source Voltage	20	V
V_{GS}	Gate to Source Voltage	±20	V
	Continuous Drain Current (Package Limit)	22	А
ID	Continuous Drain Current ⁽¹⁾	10	А
I _{DM}	Pulsed Drain Current, $T_A = 25^{\circ}C^{(2)}$	52	А
PD	Power Dissipation ⁽¹⁾	2.5	W
T _J , T _{STG}	Operating Junction and Storage Temperature Range	-55 to 150	°C
E _{AS}	Avalanche Energy, single pulse I_D = 19A, L = 0.1mH, R_G = 25\Omega	18	mJ

(1) $R_{\theta JA} = 50$ on $1in^2$ Cu (2 oz.) on .060" thick FR4 PCB.

(2) Pulse duration 10µs, duty cycle ≤2%



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ELECTRICAL CHARACTERISTICS

$T_A = 25^{\circ}C$, unless otherwise specified

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
Static Cl	naracteristics				
BV _{DSS}	Drain to Source Voltage	$V_{GS} = 0V, I_D = 250\mu A$	20		V
I _{DSS}	Drain to Source Leakage Current	$V_{GS} = 0V, V_{DS} = 20V$		1	μA
I _{GSS}	Gate to Source Leakage Current	$V_{DS} = 0V, V_{GS} = 20V$		100	nA
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_{DS} = 250 \mu A$	1.10 1.45	1.90	V
D	Drain to Source On Registeres	$V_{GS} = 4.5V, I_{DS} = 5A$	16.0	19.2	mΩ
R _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10V$, $I_{DS} = 5A$	12.0	15.0	mΩ
9 _{fs}	Transconductance	V _{DS} = 16V, I _{DS} = 5A	25		S
Dynamic	Characteristics				
C _{ISS}	Input Capacitance		320	419	pF
C _{OSS}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 10V, f = 1MHz$	184	239	pF
C _{RSS}	Reverse Transfer Capacitance		32	42	pF
R _g	Series Gate Resistance		3.8	7.6	Ω
Qg	Gate Charge Total (4.5V)		2.5	3.3	nC
Qg	Gate Charge Total (10V)		5.1	6.7	nC
Q _{gd}	Gate Charge – Gate to Drain	V _{DS} = 10V, I _{DS} = 5A	0.66		nC
Q _{gs}	Gate Charge Gate to Source		0.93		nC
Q _{g(th)}	Gate Charge at Vth		0.52		nC
Q _{OSS}	Output Charge	$V_{DS} = 10V, V_{GS} = 0V$	4.1		nC
t _{d(on)}	Turn On Delay Time		4.7		ns
t _r	Rise Time	$V_{DS} = 10V, V_{GS} = 4.5V, I_{DS} = 5A$	17.2		ns
t _{d(off)}	Turn Off Delay Time	$R_{\rm G} = 2\Omega$	9.9		ns
t _f	Fall Time		4.1		ns
Diode Cl	haracteristics				
V _{SD}	Diode Forward Voltage	$I_{DS} = 5A, V_{GS} = 0V$	0.82	1	V
Q _{rr}	Reverse Recovery Charge		10.7		nC
t _{rr}	Reverse Recovery Time	$V_{DD} = 10V, I_F = 5A, di/dt = 300A/\mu s$	19		ns

THERMAL CHARACTERISTICS

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

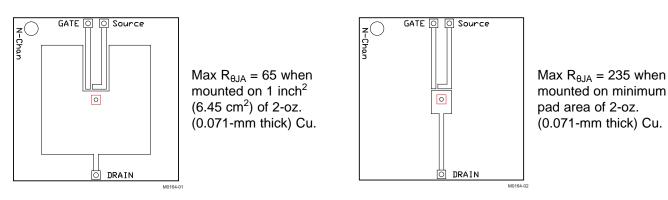
	PARAMETER	MIN	TYP	MAX	UNIT
$R_{ extsf{ heta}JC}$	Thermal Resistance Junction to Case ⁽¹⁾			4.5	°C/W
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ⁽¹⁾⁽²⁾			65	°C/W

(1) R_{θJC} is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch x 1.5-inch (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R_{θJC} is specified by design, whereas R_{θJA} is determined by the user's board design.
 (2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.



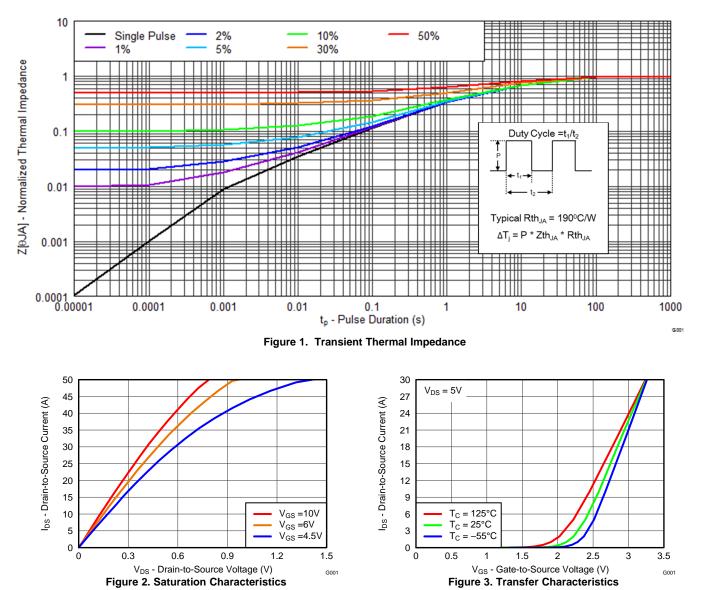
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TYPICAL MOSFET CHARACTERISTICS

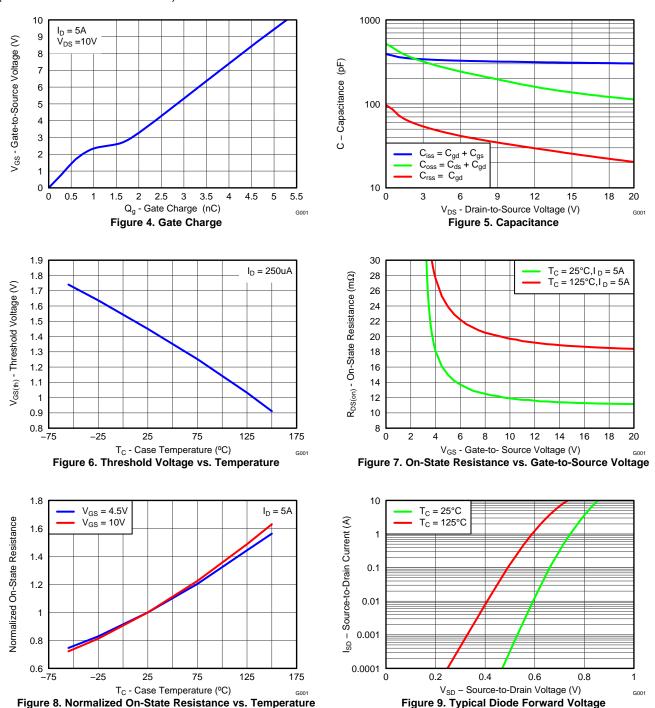
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



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TYPICAL MOSFET CHARACTERISTICS (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$



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TYPICAL MOSFET CHARACTERISTICS (continued)

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

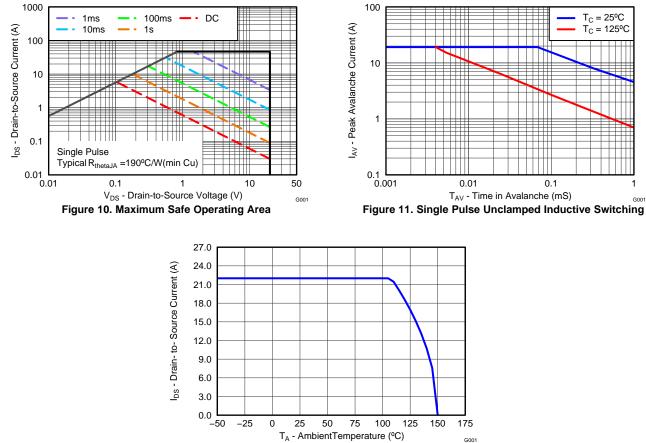


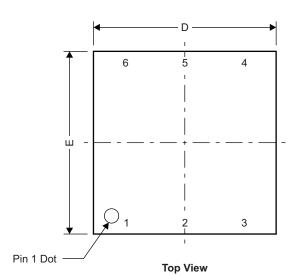
Figure 12. Maximum Drain Current vs. Temperature

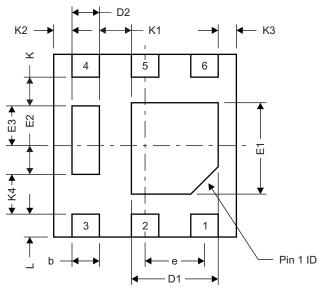
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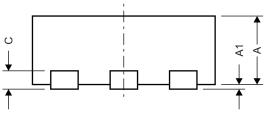
MECHANICAL DATA

Q2 Package Dimensions





Bottom View



Front View

M0165-01

DIM	MILLIMETERS			INCHES			
	MIN	NOM	MAX	MIN	MAX		
А	0.700	0.750	0.800	0.028 0.030		0.032	
A1	0.000		0.050	0.000	0.002		
b	0.250	0.300	0.350	0.010	0.012	0.014	
С		0.203 TYP			0.008 TYP		
D		2.000 TYP			0.080 TYP		
D1	0.900	0.950	1.000	0.036	0.038	0.040	
D2		0.300 TYP		0.012 TYP			
E	2.000 TYP 0.080 TYP						
E1	0.900	1.000	1.100	0.036	0.040	0.044	
E2		0.280 TYP			0.0112 TYP		
E3		0.470 TYP			0.0188 TYP		
е	0.650 BSC				0.026 TYP		
К		0.280 TYP			0.0112 TYP		
K1		0.350 TYP			0.014 TYP		
K2	0.200 TYP 0.008 TYP						
K3		0.200 TYP		0.008 TYP			
K4		0.470 TYP		0.0188 TYP			
L	0.200	0.25	0.300	0.008 0.010 0.012			

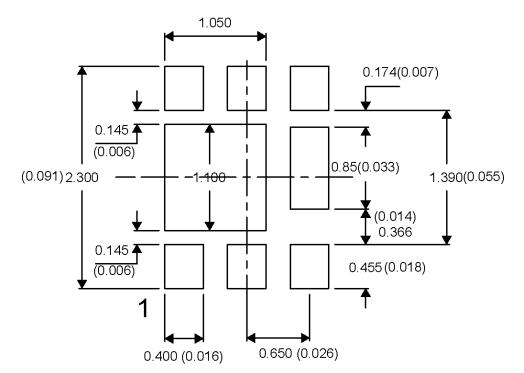
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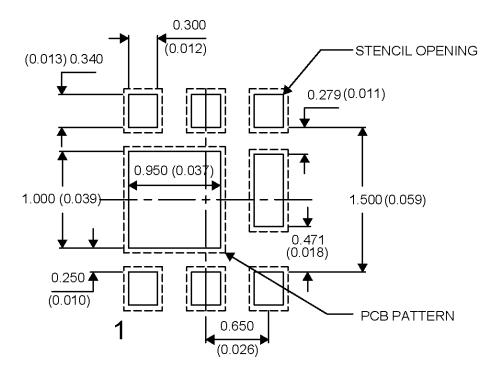
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Recommended PCB Pattern



For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

Recommended Stencil Pattern



Note: All dimensions are in mm, unless otherwise specified.

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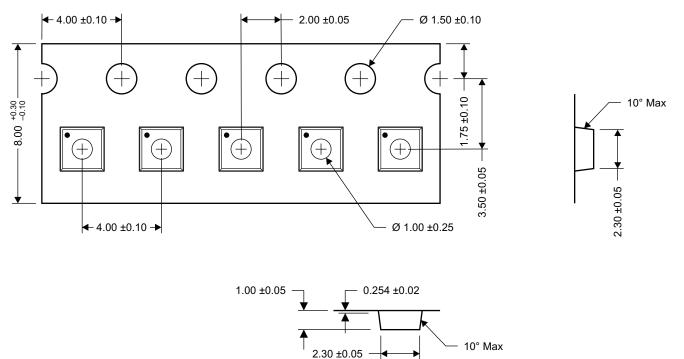
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M0168-01

NSTRUMENTS

EXAS

Q2 Tape and Reel Information



Notes: 1. Measured from centerline of sprocket hole to centerline of pocket

- 2. Cumulative tolerance of 10 sprocket holes is ±0.20
- 3. Other material available
- 4. Typical SR of form tape Max 10⁹ OHM/SQ
- 5. All dimensions are in mm, unless otherwise specified.



PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
CSD15571Q2	Active	Production	WSON (DQK) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 150	1551
CSD15571Q2.B	Active	Production	WSON (DQK) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 150	1551
CSD15571Q2G4.B	Active	Production	WSON (DQK) 6	3000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 150	1551

⁽¹⁾ **Status:** For more details on status, see our product life cycle.

(2) Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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